



Film Capacitors

Capacitors for snubbing, resonant circuits, PFC

Series/Type: **B3270*P**

Date: April 2025

Typical Applications

- PFC (Power Factor Correction)

Climatic

- Max. operating temperature: 110 °C (case)
- Climatic category (IEC 60068-1): 40/110/56

Construction

- Dielectric: polypropylene (MKP)
- Wound capacitor technology
- Plastic case (UL 94 V-0)
- Epoxy resin sealing (UL 94 V-0)

Features

- Very compact design
- Very small dimensions
- High voltage capability
- Excellent self-healing property
- Halogen free capacitors available on request
- RoHS-compatible

Terminals

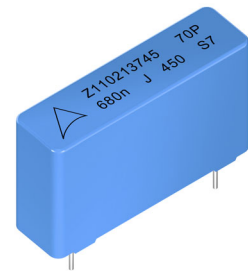
- Parallel wire leads, lead-free tinned
- Special lead lengths available on request

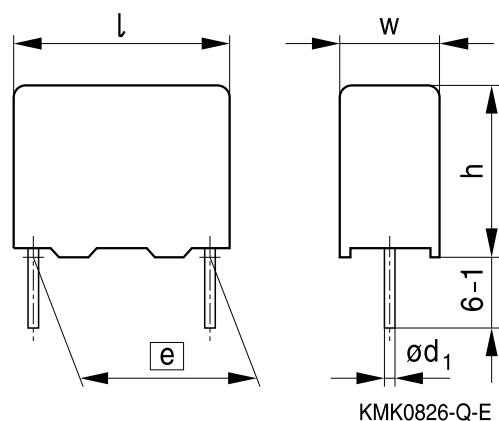
Marking

- Manufacturer's logo
- Lot number, series number
- Rated capacitance (coded)
- Capacitance Tolerance (code letter)
- Rated DC voltage
- Date of manufacture (coded)

Delivery mode

- Bulk (untaped)
- Taped (Ammo pack or reel)
- For notes on taping, refer to chapter "Taping and packing"



Dimensional drawing


Dimensions in mm

Dimensions and types

Lead spacing $e \pm 0.4$	Lead diameter $d_1 \pm 0.05$	Type
10	0.6	B32701P
15	0.8	B32702P
22.5	0.8	B32703P

Overview of available types

Lead spacing	10mm	15mm	22.5mm
Type	B32701P	B32702P	B32703P
V_R (V DC)	450 V DC		
C_R (μ F)			
0.47			
0.68			
1.0			
1.5			
2.2			

Ordering codes and packing units B32701P (lead spacing 10 mm)

V_R	C_R	Ordering code (composition see below)	Max.dimensions w x h x l mm	Ammo pack	Reel	Untaped
V DC	μF			pcs./MOQ	pcs./MOQ	pcs./MOQ
450	0.47	B32701P4474+***	5.0 x 11.0 x 13.0	3320	5200	4000
	0.68	B32701P4684+***	6.0 x 12.0 x 13.0	2720	4400	4000
	1.00	B32701P4105+***	7.0 x 16.0 x 13.0	3360	3600	4000
	1.50	B32701P4155+***	8.0 x 17.5 x 13.0	2960	3200	2000
	2.20	B32701P4225+***	9.5 x 19.5 x 13.0	-	-	2000

Ordering codes and packing units B32702P (lead spacing 15 mm)

V_R	C_R	Ordering code (composition see below)	Max.dimensions w x h x l mm	Ammo pack	Reel	Untaped
V DC	μF			pcs./MOQ	pcs./MOQ	pcs./MOQ
450	0.68	B32702P4684+***	5.0 x 10.5 x 18.0	4680	5200	4000
	1.00	B32702P4105+***	6.0 x 11.0 x 18.0	3840	4400	4000
	1.50	B32702P4155+***	7.0 x 12.5 x 18.0	3320	3600	4000
	2.20	B32702P4225+***	8.5 x 14.5 x 18.0	2720	2800	2000

Ordering codes and packing units B32703P (lead spacing 22.5 mm)

V_R	C_R	Ordering code (composition see below)	Max.dimensions w x h x l mm	Ammo pack	Reel	Untaped
V DC	μF			pcs./MOQ	pcs./MOQ	pcs./MOQ
450	2.20	B32703P4225+***	6.0 x 15.0 x 26.5	2720	2800	2880

MOQ = Minimum Order Quantity, consisting of 4 packing units.

Intermediate capacitance values and closer tolerance on request. Other lead lengths upon request.

Composition of ordering code

+ = Capacitance tolerance code:

J = $\pm 5\%$

K = $\pm 10\%$

*** = Packaging code:

289 = Straight terminals, Ammo pack

189 = Straight terminals, Reel

000 = Straight terminals, Untaped (lead length 6 – 1 mm)

Technical data

All data given at $T = 20\text{ °C}$, unless otherwise specified.

Rated temperature T_R	+85 °C		
Operation temperature range	Max. operating temperature $T_{op, max}$	+110 °C ¹⁾	
	Upper category temperature T_{max}	+100 °C	
	Lower category temperature T_{min}	−40 °C	
	Rated temperature T_R	+85 °C	
Dissipation factor $\tan \delta$ (in 10^{-3}) at 20°C (upper limit values)	LS 10 1 kHz: 1.0 100 kHz: 30.0	LS 15 1 kHz: 1.0 100 kHz: 30.0	LS 22.5 1 kHz: 1.0 100 kHz: 45.0
Insulation resistance R_{ins} at 100 V or time constant $\tau = C_R \cdot R_{ins}$ at 20 °C, rel. humidity $\leq 65\%$ (minimum as delivered values)	10000 s		
Test voltage (terminal to terminal)	$1.4 \cdot V_{R,DC}$, 2 s		
Peak current $I_p(A)$	$C (\mu F) \times dV/dt$		
$V_{R,DC}$ at 85 °C	450 V DC		
Continuous operation voltage V_{op} at 110 °C	380 V DC		
Continuous operating voltage V_{op} For temperature $85\text{ °C} < T \leq 110\text{ °C}$ Voltage derating	0.62%/°C of V_{op} derating compared to V_{op} at 85 °C		
Reliability Failure rate λ Service life t_{SL}	10 fit ($\leq 1 \cdot 10^{-9}$) at $0.5 \cdot V_{R,DC}$, 40 °C 50000h at $V_{R,DC}$ and 85 °C For conversion to other operating conditions and temperatures, refer to chapter "Reliability, 2 Reliability."		

1) 110 °C is the maximum operating temperature (ambient temperature + self-heating), detailed information can refer to I_{rms} derating versus ambient temperature curve in page 11.

Pulse handling capability

“dV/dt” represents the maximum permissible voltage change per unit of time for non-sinusoidal voltages, expressed in V/ms.

“k₀” represents the maximum permissible pulse characteristic of the waveform applied to the capacitor, expressed in V²/ms.

Note:

The values of dV/dt and k₀ provided below must not be exceeded in order to avoid damaging the capacitor. These parameters are given for isolated pulses in such a way that the heat generated by one pulse will be completely dissipated before applying the next pulse. For a train of pulse, please refer to the curves of permissible AC voltage-current versus frequency.

dV/dt values

Lead spacing	10 mm	15 mm	22.5 mm
V _R V DC	dV/dt in V/μs		
450	60	25	15

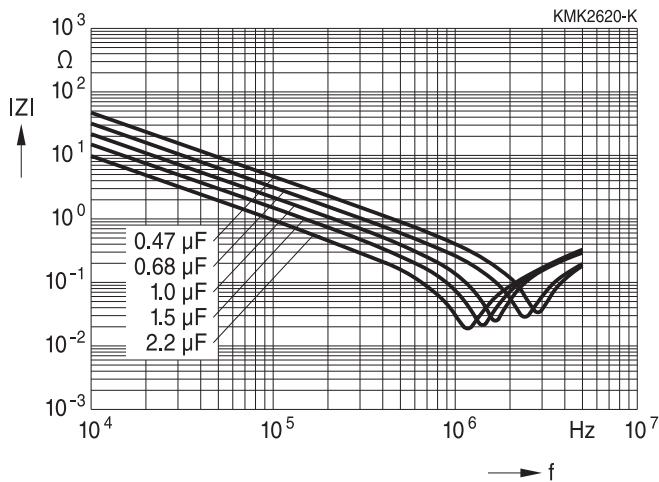
K₀ values

Lead spacing	10 mm	15 mm	22.5 mm
V _R V DC	K ₀ in V ² /μs		
450	54000	22500	13500

Characteristics curves

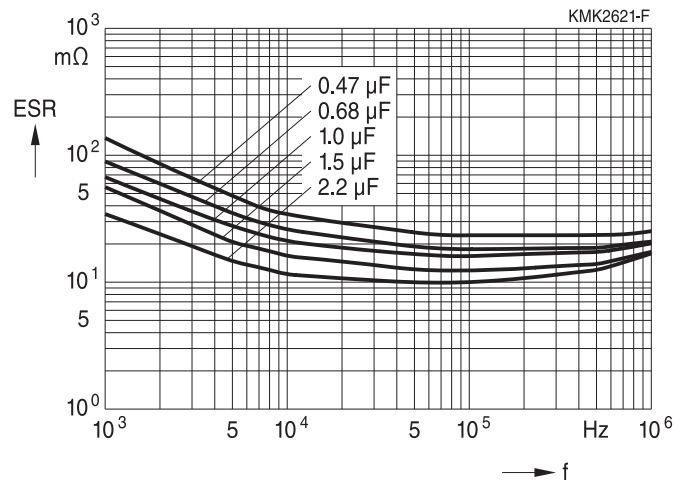
Impedance Z versus frequency f
(Typical values)

Lead spacing 10.0 mm / B32701P4 (2 pins)
450 V DC



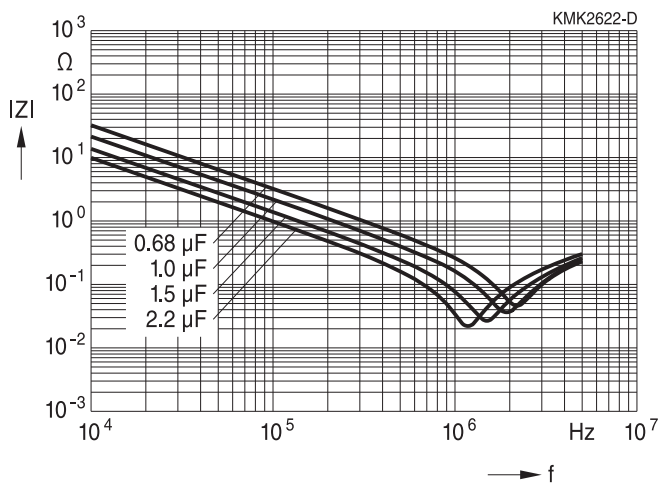
ESR versus frequency f
(Typical values)

Lead spacing 10.0 mm / B32702P4 (2 pins)
450 V DC



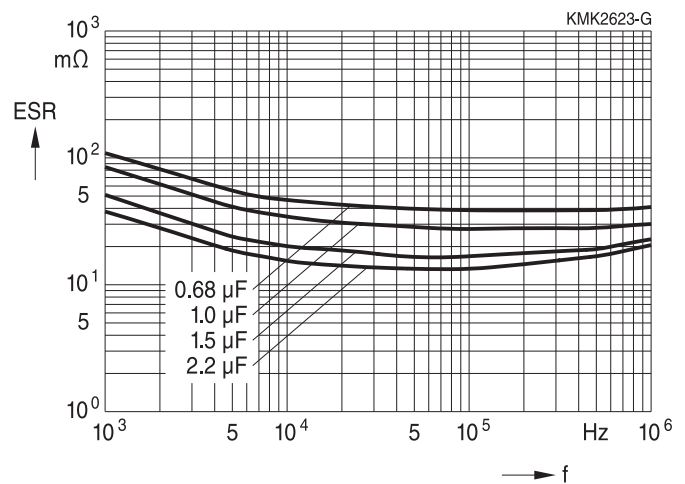
Impedance Z versus frequency f
(Typical values)

Lead spacing 15.0 mm / B32702P4 (2 pins)
450 V DC



ESR versus frequency f
(Typical values)

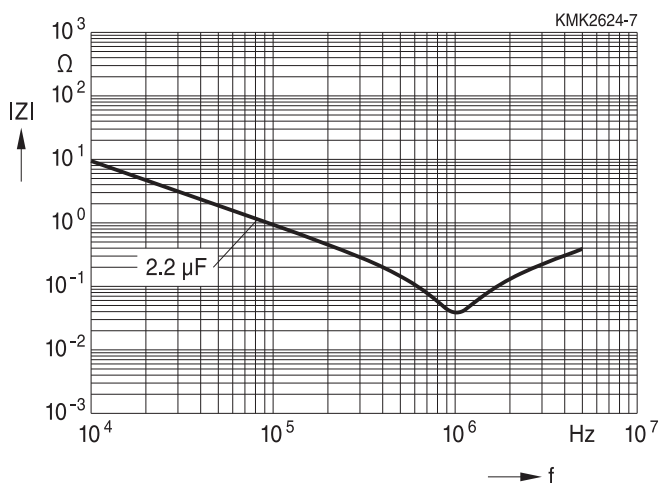
Lead spacing 15.0 mm / B32702P4 (2 pins)
450 V DC



Characteristics curves

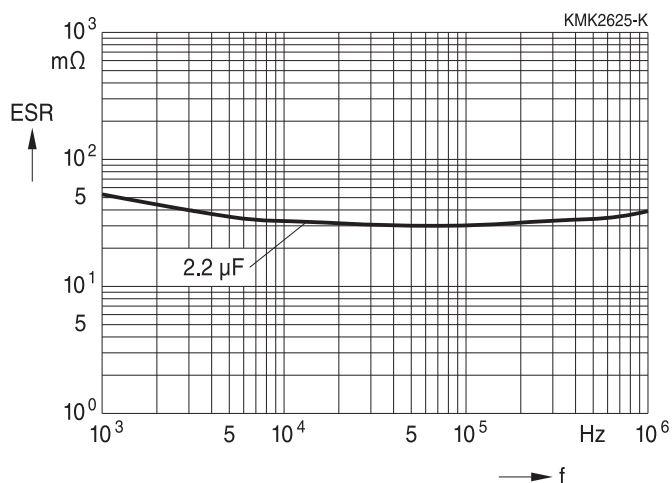
Impedance Z versus frequency f
(Typical values)

Lead spacing 22.5 mm / B32703P4 (2 pins)
450 V DC



ESR versus frequency f
(Typical values)

Lead spacing 15.0 mm / B32703P4 (2 pins)
450 V DC

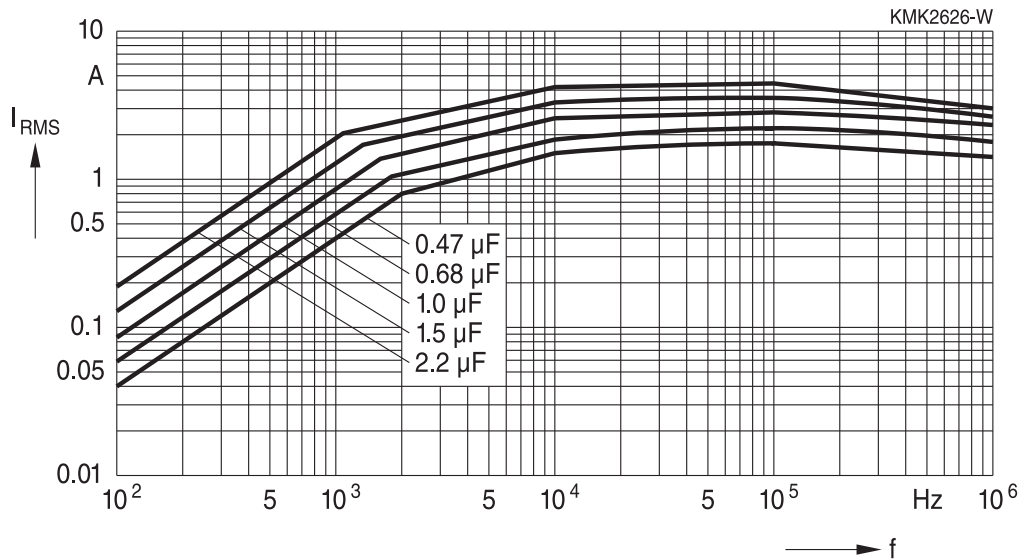


Permissible current I_{RMS} versus frequency f (for sinusoidal waveforms, ambient temperature $T_A \leq 85^\circ\text{C}$, $\Delta T \leq 15^\circ\text{C}$)

For $T_A > 85^\circ\text{C}$, please use derating factor F_T .

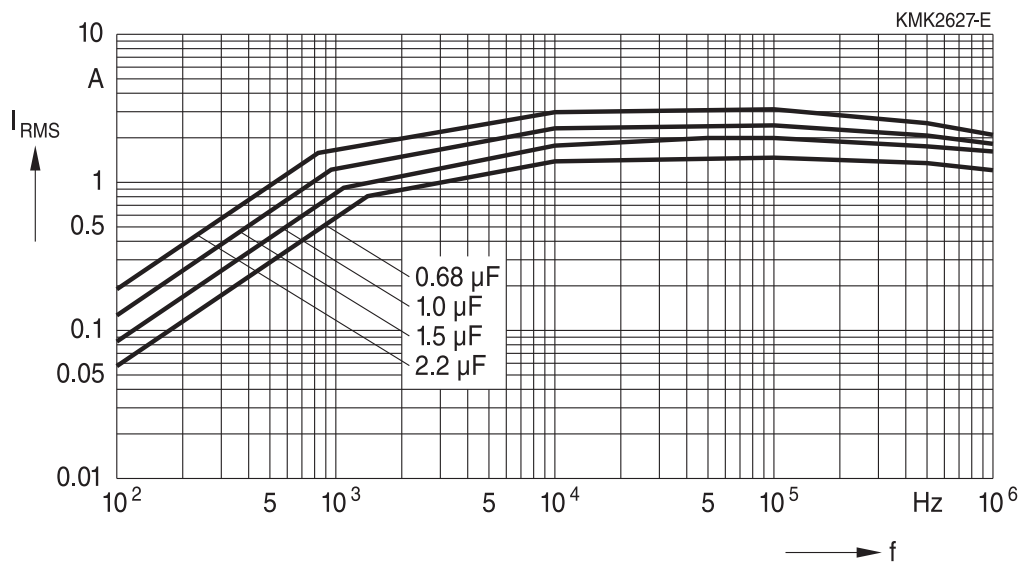
Lead spacing 10 mm

450 V DC



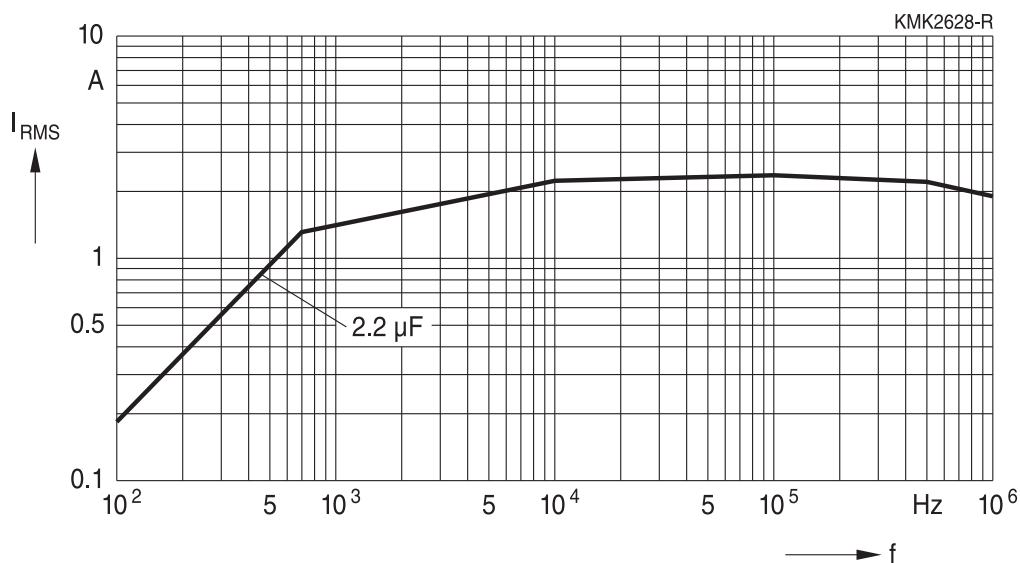
Lead spacing 15 mm

450 V DC



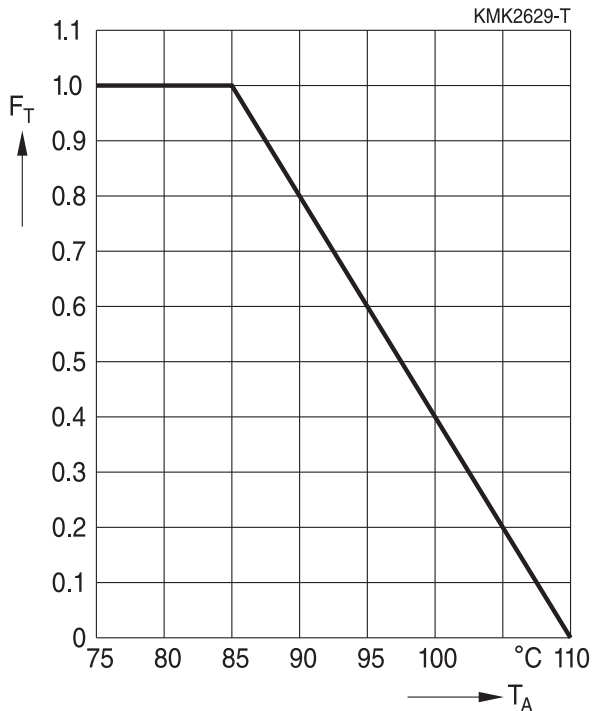
Lead spacing 22.5 mm

450 V DC



Maximum current (I_{RMS}) versus frequency and temperature for $T_A > 85^\circ\text{C}$

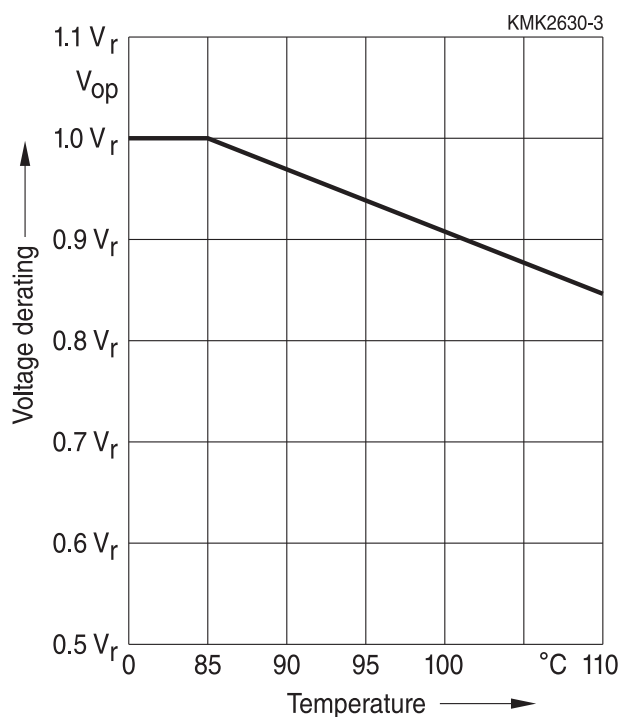
The graphs described in the previous section for the permissible current (I_{RMS}) versus frequency are given for a maximum ambient temperature $T_A \leq 85^\circ\text{C}$. In case of higher ambient temperatures (T_A), the self-heating (ΔT) of the component must be reduced to avoid that temperature of the component ($T_{op} = T_A + \Delta T$) reaches values above maximum operating temperature. The factor F_T shall be applied in the following way:



Maximum I_{RMS} as function of the ambient temperature:

$$I_{RMS}(T_A) = I_{RMS, T_A \leq 85^\circ\text{C}} \cdot F_T(T_A)$$

Maximum permissible DC voltage as a function of temperature (voltage derating)



Reliability Items

Test description	Reference	Test conditions	Performance requirements
0-Electrical parameters	IEC 60384-16:2019	Capacitance: 1 kHz,1.0 V; Loss factor: 1 kHz, 1.0 V; 100 KHz, 1.0 V; Voltage proof: 1.4 U _R , 1 min; Insulation Resistance: 100 V,1 min;	Within specified limits
1-Robustness of terminations	IEC 60068-2-21:2006	Tensile strength (test Ua1)	Capacitance and tan within tan δ specified limits
		Wire diameter Tensile force	
		0.5 < d ≤ 0.8 mm 10 N	
2-Rapid change of temperature	IEC 60384-16:2019	T _A = lower category temperature T _B = upper category temperature Five cycles, duration t = 30 min	ΔC/C ₀ ≤ 2% Δ tan δ ≤ 0.002 R _{ins} ≥ 50% of initial limit
Vibration	IEC 60384-16:2019	Test F _C : vibration sinusoidal Displacement: 0.75 mm Accleration: 98 m/s ² Whichever is the lower amplitude Frequency: 10 Hz ... 500 Hz Test duration: 3 orthogonal axes, 2 hours each axe	No visible damage
3-Bump	IEC 60384-16:2019	Test Eb: Total 4000 bumps with 400 m/s ² mounted on PCB Duration: 6 ms	No visible damage ΔC/C ₀ ≤ 2% Δ tan δ ≤ 0.002 R _{ins} ≥ 50% of initial limit
4-Climatic Sequence	IEC 60384-16:2019	Dry heat Tb / 16 h Damp heat cyclic, 1st cycle +55 °C / 24 h / 95% ... 100% RH Cold Ta / 2 h Damp heat cyclic, 5 cycles +55 °C / 24 h / 95% ... 100% RH	No visible damage ΔC/C ₀ ≤ 3% Δ tan δ ≤ 0.002 R _{ins} ≥ 50% of initial limit
5- Damp heat, loading		Test Ca 40 °C / 93% RH / V _{R,DC} /1000 hours	No visible damage ΔC/C ₀ ≤ 10%
6-Endurance A		85 °C / 1.11 V _{R,DC} / 1000 hours	No visible damage ΔC/C ₀ ≤ 5% Δ tan δ ≤ 0.004 R _{ins} ≥ 50% of initial limit
7-Endurance B		110 °C / 1.11 V _{op} / 1000 hours	No visible damage ΔC/C ₀ ≤ 5% Δ tan δ ≤ 0.004 R _{ins} ≥ 50% of initial limit

Soldering

Solderability of leads

The solderability of terminal leads is tested to IEC 60068-2-20:2008, test Ta, method 1.

Before a solderability test is carried out, terminals are subjected to accelerated ageing (to IEC 60068-2-2:2007, test Ba: 4 h exposure to dry heat at 155 °C). Since the ageing temperature is far higher than the upper category temperature of the capacitors, the terminal wires should be cut off from the capacitor before the ageing procedure to prevent the solderability being impaired by the products of any capacitor decomposition that might occur.

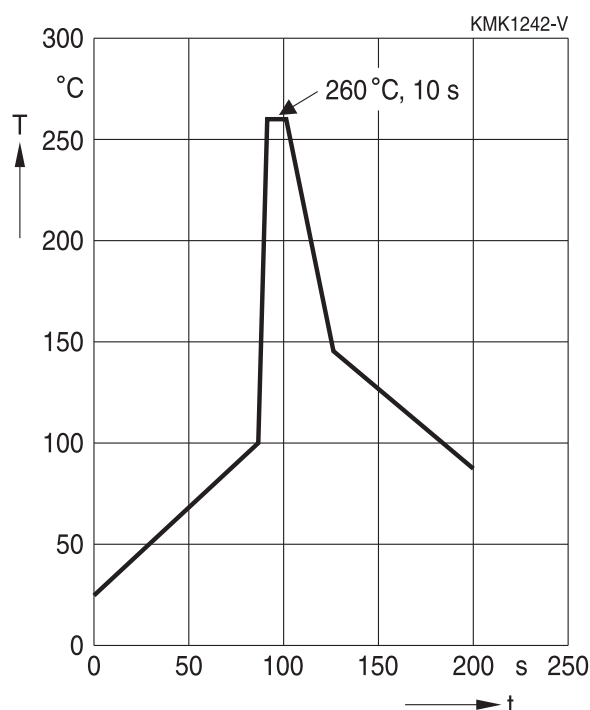
Solder bath temperature	235 ± 5 °C
Soldering time	2.0 ± 0.5 s
Immersion depth	2.0 +0/−0.5 mm from capacitor body or seating plane
Evaluation criteria: Visual inspection	Wetting of wire surface by new solder ≥ 90%, free-flowing solder

Resistance to soldering heat

Resistance to soldering heat is tested to IEC 60068-2-20:2008, test Tb, method 1.

Conditions:

Series		Solder bath temperature	Soldering time
MKT	boxed (except 2.5 x 6.5 x 7.2 mm)	260 ± 5 °C	10 ± 1 s
	coated		
	uncoated (lead spacing > 10 mm)		
MFP			
MKP	(lead spacing > 7.5 mm)		
MKT	boxed (case 2.5 x 6.5 x 7.2 mm)		5 ± 1 s
MKP	(lead spacing ≤ 7.5 mm)		< 4 s recommended soldering profile for MKT uncoated (lead spacing ≤ 10 mm) and insulated (B32559)
MKT	uncoated (lead spacing ≤ 10 mm) insulated (B32559)		



Immersion depth	2.0 +0/−0.5 mm from capacitor body or seating plane
Shield	Heat-absorbing board, (1.5 ± 0.5) mm thick, between capacitor body and liquid solder
Evaluation criteria:	
Visual inspection	No visible damage
$\Delta C/C_0$	2% for MKT/MKP/MFP 5% for EMI suppression capacitors
$\tan \delta$	As specified in sectional specification

General notes on soldering

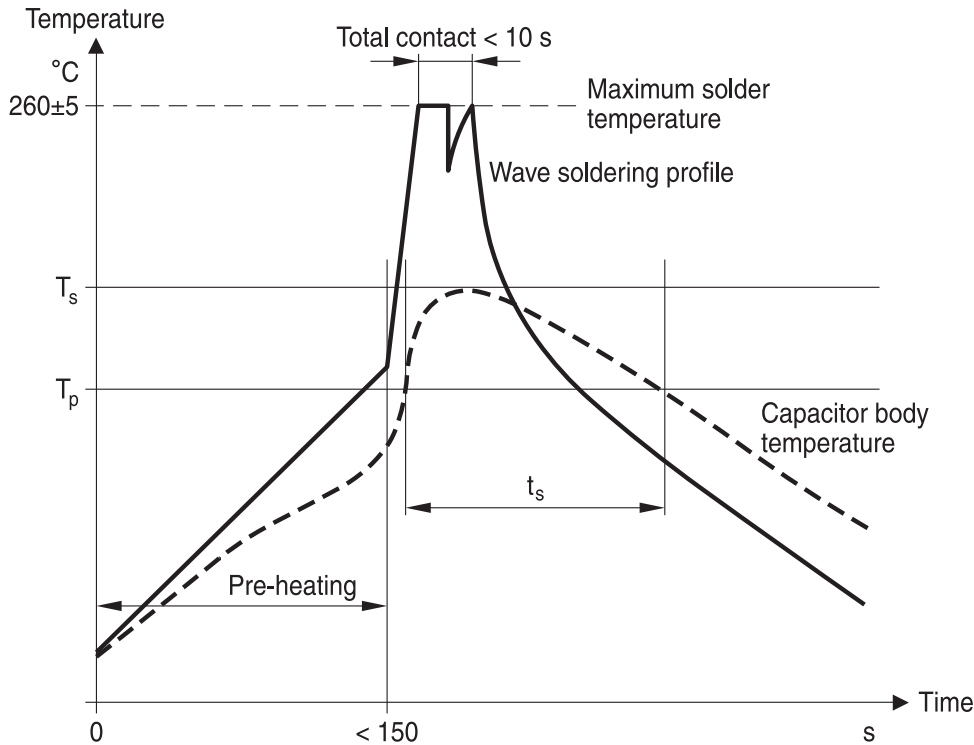
Permissible heat exposure loads on film capacitors are primarily characterized by the upper category temperature $T_{\max}$. Long exposure to temperatures above this type-related temperature limit can lead to changes in the plastic dielectric and thus change irreversibly a capacitor's electrical characteristics. For short exposures (as in practical soldering processes) the heat load (and thus the possible effects on a capacitor) will also depend on other factors like:

- Pre-heating temperature and time
- Forced cooling immediately after soldering
- Terminal characteristics:
diameter, length, thermal resistance, special configurations (e.g. crimping)
- Height of capacitor above solder bath
- Shadowing by neighboring components
- Additional heating due to heat dissipation by neighboring components
- Use of solder-resist coatings

The overheating associated with some of these factors can usually be reduced by suitable countermeasures. For example, if a pre-heating step cannot be avoided, an additional or reinforced cooling process may possibly have to be included.

TDK Recommendations

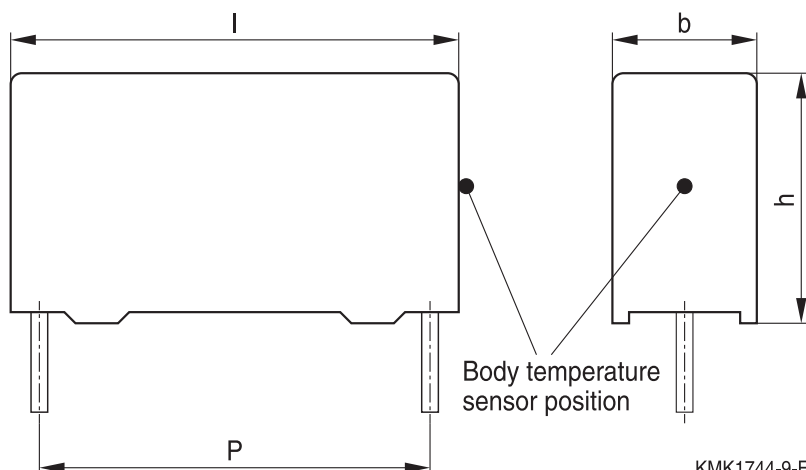
As a reference, the recommended wave soldering profile for our film capacitors is as follows:



T_s : Capacitor body maximum temperature at wave soldering

T_p : Capacitor body maximum temperature at pre-heating

KMK1745-A-E



KMK1744-9-E

Capacitors for snubbing, resonant circuits, PFC

Body temperature should follow the description below:

- MKP capacitor
 - During pre-heating: $T_p \leq 110\text{ °C}$
 - During soldering: $T_s \leq 120\text{ °C}$, $t_s \leq 45\text{ s}$
- MKT capacitor
 - During pre-heating: $T_p \leq 125\text{ °C}$
 - During soldering: $T_s \leq 160\text{ °C}$, $t_s \leq 45\text{ s}$

When SMD components are used together with leaded ones, the film capacitors should not pass into the SMD adhesive curing oven. The leaded components should be assembled after the SMD curing step.

Leaded film capacitors are not suitable for reflow soldering.

In order to ensure proper conditions for manual or selective soldering, the body temperature of the capacitor (T_s) must be $\leq 120\text{ °C}$.

One recommended condition for manual soldering is that the tip of the soldering iron should be $< 360\text{ °C}$ and the soldering contact time should be no longer than 3 seconds.

For uncoated MKT capacitors with lead spacings $\leq 10\text{ mm}$ (B32560/B32561) the following measures are recommended:

- pre-heating to not more than 110 °C in the preheater phase
- rapid cooling after soldering

Cleaning

To determine whether the following solvents, often used to remove flux residues and other substances, are suitable for the capacitors described, refer to the table below:

Type	Ethanol, isopropanol, n-propanol	n-propanol-water mixtures, water with surface tension-reducing tensides (neutral)
MKT (uncoated)	Suitable	Unsuitable
MKT, MKP, MFP (coated/boxed)		Suitable

Even when suitable solvents are used, a reversible change of the electrical characteristics may occur in uncoated capacitors immediately after they are washed. Thus it is always recommended to dry the components (e.g. 4 h at 70 °C) before they are subjected to subsequent electrical testing.

Caution:

Consult us first if you wish to use new solvents!

Embedding of capacitors in finished assemblies

In many applications, finished circuit assemblies are embedded in plastic resins. In this case, both chemical and thermal influences of the embedding ("potting") and curing processes must be taken into account.

Our experience has shown that the following potting materials can be recommended: non-flexible epoxy resins with acid-anhydride hardeners; chemically inert, non-conducting fillers; maximum curing temperature of 100 °C .

Caution:

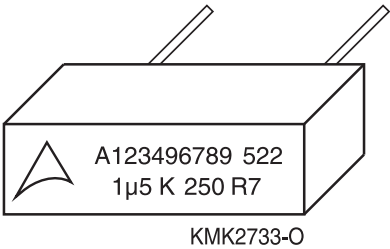
Consult us first if you wish to embed uncoated types!

Marking

Capacitor markings

Depending on the capacitor size, the markings are positioned either on the side and/or the top of the component. The coded forms specified in IEC 60062:2004 are used to indicate the rated capacitance, capacitance tolerance and date of manufacture.

The lot number (production batch number) ensures unique identification of a particular capacitor and allows, together with the date of manufacture, exact assignment to the process data of the entire production run (traceability).

Marking example	Remarks
	Manufacturer's logo 1st line: Lot number (1 character, 9 digits), series number (film material is coded in the series number) 2nd line: C_R, tolerance, V_R, date of manufacture (year and month coded)

Codes for rated capacitance

Rated capacitance	To IEC 60062	Short code
100 pF	100p	n1
150 pF	150p	n15
1.0 nF	1n0	1n
1.5 nF	1n5	
10 nF	10n	
100 nF	100n	μ1
150 nF	150n	μ15
1.0 μF	1μ0	1μ
1.5 μF	1μ5	
10 μF	10μ	
15 μF	15μ	

Codes for capacitance tolerance

Capacitance tolerance	Code letter	Remark
	A	Capacitance tolerances for which no code letter is defined can be indicated by an A. The meaning of code A must then be mutually specified in other documentation.
±2.5%	H	
±5%	J	
±10%	K	
±20%	M	

Codes for date of manufacture (to IEC 60062:2004)

Code for year				Code for month			
Year	Code letter	Year	Code letter	Month	Code numeral	Month	Code numeral/letter
2023	R	2029	X	January	1	July	7
2024	S	2030	A	February	2	August	8
2025	T	2031	B	March	3	September	9
2026	U	2032	C	April	4	October	O
2027	V	2033	D	May	5	November	N
2028	W	2034	E	June	6	December	D

E.g.: J5 2017 May

Marking types

The capacitors may have either an ink-jet marking or a laser marking. The main advantage of laser marking is that it cannot be removed by solvents, which ensures the reliable identification of the capacitor. Moreover, because the laser marking process reduces the amount of chemicals used, it is an environmentally friendly marking solution.

Cautions and warnings

- Do not exceed the upper category temperature (UCT).
- Do not apply any mechanical stress to the capacitor terminals.
- Avoid any compressive, tensile or flexural stress.
- Do not move the capacitor after it has been soldered to the PC board.
- Do not pick up the PC board by the soldered capacitor.
- Do not place the capacitor on a PC board whose PTH hole spacing differs from the specified lead spacing.
- Do not exceed the specified time or temperature limits during soldering.
- Avoid external energy inputs, such as fire or electricity.
- Avoid overload of the capacitors.
- Consult us if application is with severe temperature and humidity condition.
- There are no serviceable or repairable parts inside the capacitor. Opening the capacitor or any attempts to open or repair the capacitor will void the warranty and liability of TDK Electronics.
- Please note that the standards referred to in this publication may have been revised in the meantime.

The table below summarizes the safety instructions that must always be observed. A detailed description can be found in the relevant sections of the chapters "General technical information" and "Mounting guidelines".

Topic	Safety information	Reference chapter "General technical information"
Storage conditions	Make sure that capacitors are stored within the specified range of time, temperature and humidity conditions.	4.5 "Storage conditions"
Flammability	Avoid external energy, such as fire or electricity (passive flammability), avoid overload of the capacitors (active flammability) and consider the flammability of materials.	5.3 "Flammability"
Resistance to vibration	Do not exceed the tested ability to withstand vibration. The capacitors are tested to IEC 60068-2-6:2007. TDK Electronics offers film capacitors specially designed for operation under more severe vibration regimes such as those found in automotive applications. Consult our catalog "Film Capacitors for Automotive Electronics".	5.2 "Resistance to vibration"
Soldering	Do not exceed the specified time or temperature limits during soldering.	1 "Soldering"
Cleaning	Use only suitable solvents for cleaning capacitors.	2 "Cleaning"
Embedding of capacitors in finished assemblies	When embedding finished circuit assemblies in plastic resins, chemical and thermal influences must be taken into account. Caution: Consult us first, if you also wish to embed other uncoated component types!	3 "Embedding of capacitors in finished assemblies"

Display of ordering codes for TDK Electronics products

The ordering code for one and the same product can be represented differently in data sheets, data books, other publications, on the company website, or in order-related documents such as shipping notes, order confirmations and product labels. The varying representations of the ordering codes are due to different processes employed and do not affect the specifications of the respective products.

Detailed information can be found on the Internet under www.tdk-electronics.tdk.com/orderingcodes.

Correlation of data sheet values and modelling tool outputs

Data sheet values and results of design tools may deviate as they have not been derived in the same context.

While data sheets show individual parameter statements without considering a possible dependency to other parameters. Tools model a complete given scenario as input and processed inside the tool.

Furthermore as we constantly strive to improve our models, the results of tools can change over time and be a non-binding indication only.

Symbols and terms

Symbol	English	German
α	Heat transfer coefficient	Wärmeübergangszahl
α_C	Temperature coefficient of capacitance	Temperaturkoeffizient der Kapazität
A	Capacitor surface area	Kondensatoroberfläche
β_C	Humidity coefficient of capacitance	Feuchteffizient der Kapazität
C	Capacitance	Kapazität
C_R	Rated capacitance	Nennkapazität
ΔC	Absolute capacitance change	Absolute Kapazitätsänderung
$\Delta C/C$	Relative capacitance change (relative deviation of actual value)	Relative Kapazitätsänderung (relative Abweichung vom Ist-Wert)
$\Delta C/C_R$	Capacitance tolerance (relative deviation from rated capacitance)	Kapazitätstoleranz (relative Abweichung vom Nennwert)
dt	Time differential	Differentielle Zeit
Δt	Time interval	Zeitintervall
ΔT	Absolute temperature change (self-heating)	Absolute Temperaturänderung (Selbsterwärmung)
$\Delta \tan \delta$	Absolute change of dissipation factor	Absolute Änderung des Verlustfaktors
ΔV	Absolute voltage change	Absolute Spannungsänderung
dV/dt	Time differential of voltage function (rate of voltage rise)	Differentielle Spannungsänderung (Spannungsflankensteilheit)
$\Delta V/\Delta t$	Voltage change per time interval	Spannungsänderung pro Zeitintervall
E	Activation energy for diffusion	Aktivierungsenergie zur Diffusion
ESL	Self-inductance	Eigeninduktivität
ESR	Equivalent series resistance	Ersatz-Serienwiderstand
f	Frequency	Frequenz
f_1	Frequency limit for reducing permissible AC voltage due to thermal limits	Grenzfrequenz für thermisch bedingte Reduzierung der zulässigen Wechselspannung
f_2	Frequency limit for reducing permissible AC voltage due to current limit	Grenzfrequenz für strombedingte Reduzierung der zulässigen Wechselspannung
f_r	Resonant frequency	Resonanzfrequenz
F_D	Thermal acceleration factor for diffusion	Therm. Beschleunigungsfaktor zur Diffusion
F_T	Derating factor	Deratingfaktor
i	Current (peak)	Stromspitze
I_C	Category current (max. continuous current)	Kategoriestrom (max. Dauerstrom)
I_{RMS}	(Sinusoidal) alternating current, root-mean-square value	(Sinusförmiger) Wechselstrom
i_z	Capacitance drift	Inkonstanz der Kapazität
k_0	Pulse characteristic	Impulskennwert
L_S	Series inductance	Serieninduktivität
λ	Failure rate	Ausfallrate

Symbol	English	German
λ_0	Constant failure rate during useful service life	Konstante Ausfallrate in der Nutzungsphase
λ_{test}	Failure rate, determined by tests	Experimentell ermittelte Ausfallrate
P_{diss}	Dissipated power	Abgegebene Verlustleistung
P_{gen}	Generated power	Erzeugte Verlustleistung
Q	Heat energy	Wärmeenergie
ρ	Density of water vapor in air	Dichte von Wasserdampf in Luft
R	Universal molar constant for gases	Allg. Molarkonstante für Gas
R	Ohmic resistance of discharge circuit	Ohmscher Widerstand des Entladekreises
R_i	Internal resistance	Innenwiderstand
R_{ins}	Insulation resistance	Isolationswiderstand
R_p	Parallel resistance	Parallelwiderstand
R_s	Series resistance	Serienwiderstand
S	severity (humidity test)	Schärfegrad (Feuchtetest)
t	Time	Zeit
T	Temperature	Temperatur
τ	Time constant	Zeitkonstante
$\tan \delta$	Dissipation factor	Verlustfaktor
$\tan \delta_D$	Dielectric component of dissipation factor	Dielektrischer Anteil des Verlustfaktors
$\tan \delta_p$	Parallel component of dissipation factor	Parallelanteil des Verlustfaktors
$\tan \delta_s$	Series component of dissipation factor	Serienanteil des Verlustfaktors
T_A	Temperature of the air surrounding the component	Temperatur der Luft, die das Bauteil umgibt
T_{max}	Upper category temperature	Obere Kategorietemperatur
T_{min}	Lower category temperature	Untere Kategorietemperatur
t_{OL}	Operating life at operating temperature and voltage	Betriebszeit bei Betriebstemperatur und -spannung
T_{op}	Operating temperature, $T_A + \Delta T$	Betriebstemperatur, $T_A + \Delta T$
T_R	Rated temperature	Nenntemperatur
T_{ref}	Reference temperature	Referenztemperatur
t_{SL}	Reference service life	Referenz-Lebensdauer
V_{AC}	AC voltage	Wechselspannung
V_C	Category voltage	Kategoriespannung
$V_{\text{C,RMS}}$	Category AC voltage	(Sinusförmige) Kategorie-Wechselspannung
V_{CD}	Corona-discharge onset voltage	Teilentlade-Einsatzspannung
V_{ch}	Charging voltage	Ladespannung
V_{DC}	DC voltage	Gleichspannung
V_{FB}	Fly-back capacitor voltage	Spannung (Flyback)

Symbol	English	German
V_i	Input voltage	Eingangsspannung
V_o	Output voltage	Ausgangssspannung
V_{op}	Operating voltage	Betriebsspannung
V_p	Peak pulse voltage	Impuls-Spitzenspannung
V_{pp}	Peak-to-peak voltage Impedance	Spannungshub
V_R	Rated voltage	Nennspannung
$\hat{V}_R$	Amplitude of rated AC voltage	Amplitude der Nenn-Wechselspannung
V_{RMS}	(Sinusoidal) alternating voltage, root-mean-square value	(Sinusförmige) Wechselspannung
V_{SC}	S-correction voltage	Spannung bei Anwendung "S-correction"
V_{sn}	Snubber capacitor voltage	Spannung bei Anwendung "Beschaltung"
Z	Impedance	Scheinwiderstand
e	Lead spacing	Rastermaß

Important notes

The following applies to all products named in this publication:

- 1 Some parts of this publication contain **statements about the suitability of our products for certain areas of application**. These statements are based on our knowledge of typical requirements that are often placed on our products in the areas of application concerned. We nevertheless expressly point out **that such statements cannot be regarded as binding statements about the suitability of our products for a particular customer application**. As a rule we are either unfamiliar with individual customer applications or less familiar with them than the customers themselves. For these reasons, it is always ultimately incumbent on the customer to check and decide whether a product with the properties described in the product specification is suitable for use in a particular customer application.
- 2 We also point out that **in individual cases, a malfunction of electronic components or failure before the end of their usual service life cannot be completely ruled out in the current state of the art, even if they are operated as specified**. In customer applications requiring a very high level of operational safety and especially in customer applications in which the malfunction or failure of an electronic component could endanger human life or health (e.g. in accident prevention or life-saving systems), it must therefore be ensured by means of suitable design of the customer application or other action taken by the customer (e.g. installation of protective circuitry or redundancy) that no injury or damage is sustained by third parties in the event of malfunction or failure of an electronic component.
- 3 **The warnings, cautions and product-specific notes must be observed.**
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Important notes

- 8 The trade names EPCOS, CarXield, CeraCharge, CeraDiode, CeraLink, CeraPad, CeraPlas, CSMP, CTVS, DeltaCap, DigiSiMic, FilterCap, FormFit, InsuGate, LeaXield, MediPlas, MiniBlue, MiniCell, MKD, MKK, ModCap, MotorCap, PCC, PhaseCap, PhaseCube, PhaseMod, PhiCap, PiezoBrush, PlasmaBrush, PowerHap, PQSine, PQvar, SIFERRIT, SIFI, SIKOREL, SilverCap, SIMDAD, SiMic, SIMID, SineFormer, SIOV, SurfIND, ThermoFuse, WindCap, XieldCap are **trademarks registered or pending** in Europe and in other countries. Further information will be found on the Internet at www.tdk-electronics.tdk.com/trademarks.

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